


<b>Search Notes</b>  	<b>Application/Control No.</b>  10667029	<b>Applicant(s)/Patent Under Reexamination</b>  ALFERNESS ET AL.
	<b>Examiner</b>  TANH Q NGUYEN	<b>Art Unit</b>  2182

SEARCHED			
Class	Subclass	Date	Examiner
710	5,6,8,15-18,29,36,58,60,104 - limited search	03/14-15/06	TQN
711	150,170 - limited search	03/14-15/06	TQN
370	231,235,325,395.21,398,437,461,462,468 - limited search	03/14-15/06	TQN

SEARCH NOTES		
Search Notes	Date	Examiner
inventor search - East/eDAN; continuity - PALM	03/13/06	TQN
East Search - Results attached	03/14-15/06	TQN
Updated search - results attached; rejection maintained	09/05/06	TQN
rejection maintained	03/01/07	TQN
Consult SPE - re 112 rejections	03/02/07	TQN
rejection maintained	08/15/07	TQN
updated search - results attached	03/13-14/08	TQN
Rejection maintained	10/18/2008	TQN
Consult Richard Ellis re interpretation of data types - per rejection mailed 10/20/08	1/15/2009	TQN
Consult WQAS Padmanabhan re Summary of Claimed Subject Matter - Brief is defective	8/31/2009	TQN
OK to go the the Board with 103 rejection - per SPE Hafiz. Reevalue 112 later.	5/10/2010	TQN
Appeal Conference with SPE Hafiz and SPE Ellis	7/15/2010	TQN

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/T. Q. N / Primary Examiner.Art Unit 2182
--	--